

GDOES and XPS measurements: elemental footprint and layer thickness (IAP)

E. Grigore IAP (Institute of Atomic Physics, Romania)



This work has been carried out within the framework of the EUROfusion Consortium and has received funding from the Euratom research and training programme 2014-2018 under grant agreement No 633053. The views and opinions expressed herein do not necessarily reflect those of the European Commission.

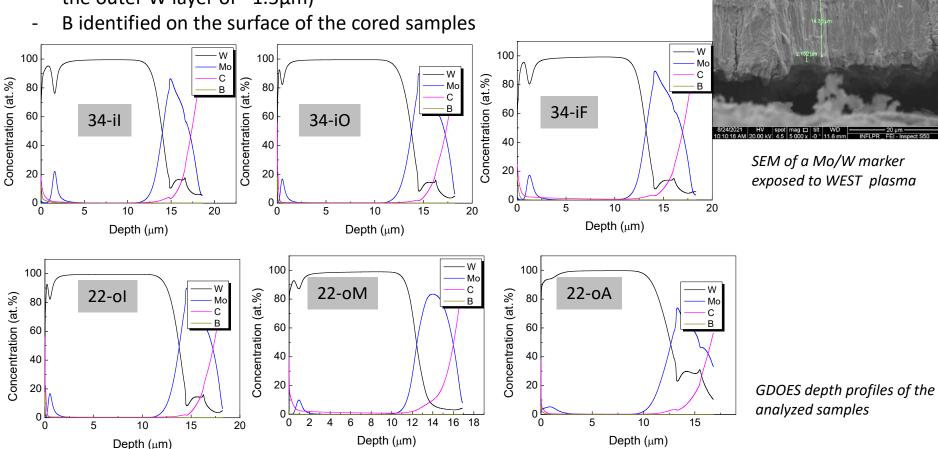
GDOES measurements:



6 cored samples were analyzed by *GDOES* (Glow Discharge Optical Emission Spectrometry): C3-34iI; C3-34iO; C3-34iF and C3-22oI; C3-22oM; C322oA

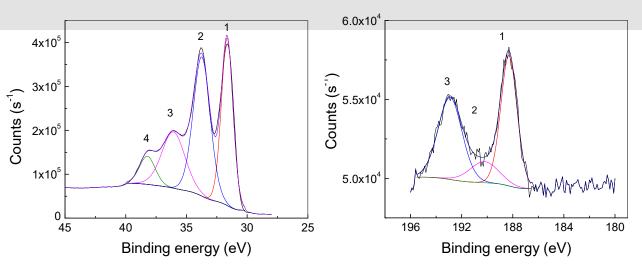
Results:

 a Mo/W/Mo/W layout observed (the outer Mo layer of ~ 0.5μm, the outer W layer of ~1.5μm)



XPS measurements and summary:





W 4f detailed spectrum (a) and respectively B1s detailed spectrum for the sample C3-34iO (b)

XPS measurements:

- W metallic W 4f7/2 and W 4f 5/2 transitions (31.5 eV and 33.6eV) along with oxide W components (36eV and 38.2eV)
- B1s transition has 3 components: pure B (component 1 at 188.3eV), B sub-oxide (component 2 at 190.2eV) and oxide at 192.9eV)

Summary:

Sample id	XPS measurements				GDOES measurement	Position of second Mo to surface
	W (at.%)	C (at.%)	O (at.%)	B (at.%)	B (at.%)	
C3-34iI	16.78	24.62	36.78	21.82	13.72	1.2
C3-34iO	24.48	26.99	33.23	15.3	17.7	0.35
C3-34iF	16.92	33.91	39.28	9.89	15.65	0.9
C3-22oI	29.32	13.01	53.14	4.54	5.61	0.6
C3-22oM	50.73	14.53	33.91	0.82	1.42	0.65
C3-22oA	51.03	19.64	22.1	7.23	5.91	0



Thank you!